

Publications/Services Standards Conferences

FAQ Terms

- What Can

| Access? C Log-out

lables of Contents

()- Standards

O- By Author

Advanced

()- CrossRef

Member Services

O- Join IEEE

()- Access the

li i energia e ()- Access the

📾 Print Format

- Establish IEEE

Web Account

IEEE Member

Digital Library

IEEE Enterprise

File Cabinet

O- Basic

Search

Journals

& Magazines

Conference **Proceedings**

Walcome United States Patent and Trademark Office



» Search Results

IEEE Peer Review Quick Links

Welcome to IEEE Xplore Your search matched 4 of 1131693 documents. O- Home

> **Descending** order. Refine This Search:

You may refine your search by editing the current search expression or entering a new one in the text box.

A maximum of 500 results are displayed, 15 to a page, sorted by Relevance in

dmt <and> reed solomon <and> interleaver

Search

☐ Check to search within this result set

Results Key:

JNL = Journal or Magazine CNF = Conference STD = Standard

1 Optimal interleaver design for concatenated coding in DSL systems

Cao, M.; Subramanian, K.R.; Dubey, V.K.;

Electronics Letters, Volume: 35, Issue: 19, 16 Sept. 1999

Pages:1630 - 1631

[Abstract] [PDF Full-Text (200 KB)]

2 A simple byte-erasure method for improved impulse immunity in DSL

Toumpakaris, D.; Wei Yu; Cioffi, J.M.; Gardan, D.; Ouzzif, M.;

Communications, 2003. ICC '03. IEEE International Conference on , Volume:

4 , 11-15 May 2003

Pages:2426 - 2430 vol.4

[Abstract] [PDF Full-Text (263 KB)] **IEEE CNF**

3 Performance of concatenated Reed-Solomon and TCM over DMT modulation

Sharfer, I.;

Electrical and Electronics Engineers in Israel, 2002. The 22nd Convention of , 1

Dec. 2002

Pages:308 - 310

[Abstract] [PDF Full-Text (273 KB)]

4 A byte-erasure method for improved impulse immunity in DSL systems using soft information from an inner code

Toumpakaris, D.; Wei Yu; Cioffi, J.M.; Gardan, D.; Ouzzif, M.;

Communications, 2003. ICC '03. IEEE International Conference on , Volume:

4 , 11-15 May 2003

Pages:2431 - 2435 vol.4

[PDF Full-Text (264 KB)] [Abstract] **IEEE CNF**

Home | Log-cut | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account | New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online Publications | Help | FAQ| Terms | Back to Top